

# ANNEX 1 - Price book for ACADEMIC PROJECTS At DTU Nanolab Effective: January 1<sup>st</sup> - 2026

## Main changes compared to last year's price book

- New SupportLab  
*In 2025 DTU Nanolab opened our new SupportLab for processes and characterization equipment that does not require a high-end cleanroom. The SupportLab is in building 347 opposite the PolyFabLab.*
- New prices
- Tool list updated

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## 2 General information



All prices are in Danish kroner without moms. All prices are subject to change.

Service from Nanolab	Unit	External project work, Danish academia <sup>1</sup>	Horizon 2020 projects <sup>2</sup>	Horizon Europe projects <sup>2</sup>	UK95 Projects <sup>2</sup>	Internal DTU projects <sup>3</sup>
Cleanroom access (below cap) <sup>4</sup>	Kr/hour	314+44% OH	364	292	314	0
Category A tools	Kr/hour	250+44% OH	291	234	250	0
Category B tools	Kr/hour	511+44% OH	595	481	511	0
Category C tools	Kr/hour	920+44% OH	1007	871	920	0
Category D tools	Kr/hour	525+44% OH	608	490	525	0
Category E tools	Kr/hour	852+44% OH	907	826	852	0
Category P tools	Kr/hour	61+44% OH	66	59	61	0
Category S tools	Kr/hour	0	0	0	0	0
Nanolab assistance <sup>5</sup>	Kr/hour	398+ 44% OH	398	398	398	0
Materials		At cost+44% OH	At cost	At cost	At cost	At cost

**Note 1,** Use of DTU Nanolab for Research projects where the DTU partner does not hold the budget or other Danish universities are charged with the DTU cost plus overhead of 44%. The overhead of 44% is an integral part of the price and reflects the cost beyond direct cost. In special cases DTU Nanolab's Director can decide on another rate than 44% after discussion with the principal investigator.

**Note 2,** The prices shown in the monthly specifications sent from DTU Nanolab is the UK95 Projects prices. DTU AØR is responsible for charging to the correct amount according to project type. The prices are excl. overhead.

**Note 3,** DTU management have decided to support all internal projects. They are paid for as long as the department meets its required external funding for DTU Nanolab activities.

**Note 4,**

- The cap is calculated per individual and is at 20 hours per month, usage above the cap is charged as 0 kr/h.
- A maximum of 6 hours is registered per swipe. If a person forgets to swipe out, no more than 6 hours will be charged.
- Category F tools are included in the cost of cleanroom access.

**Note 5,** Cleanroom access cost will be added for work done in the cleanroom.

Service	Value	Details
Maskorder "Review" and help ordering	time used	DTU Nanolab assistance
Introductory package training	1.5 hour	DTU Nanolab assistance
Shelves for work in progress	1 m <sup>2</sup>	Area rent – note 6,7
Floor space in cleanroom and subfab/basement (mix of white and grey space)	1 m <sup>2</sup>	Area rent – note 7
Locker	0,25 m <sup>2</sup>	Area rent – note 7
Shelf in chemical cabinet in basement	0,5 m <sup>2</sup>	Area rent – note 7
Storage shelf in basement	0,25 m <sup>2</sup>	Area rent – note 7
Issuing a guest-card when user has forgotten own card	0.5 hour	DTU Nanolab assistance

**Note 6,** The area of a shelf rack is calculated as the floor area covered by the rack and 110 cm access in front. For a single shelf divide this by 5 (approximate average number of shelves in a rack) to get the value.

**Note 7,** Limited amount of this item, subject to availability, minimum period is 6 months

### 3 Specific materials priced at cost



Precious metal costs	Cost Price	Details
Gold	5.60	kr/nm
Platinum	3.23	kr/nm
Palladium	2.00	kr/nm

The cost for precious metal is for every nanometer deposited regardless of whether it is on the sample or shutter.

You are only allowed to make depositions up to a certain thickness as stated in the manual for the equipment. For larger thicknesses you need to contact Thin Film ([thinfilm@nanolab.dtu.dk](mailto:thinfilm@nanolab.dtu.dk)) for approval. The approval should be confirmed in an e-mail from a group member.

Photoresists	Cost Price	Details
DUV42S-6	8.13	kr/g
KRF M35G	2.44	kr/g
KRF M230Y	2.39	kr/g

The mass of resist is measured by internal scales in the Gamma tools.

ALD sources	Cost Price	Details
TMA	6.48	kr/s
DEZ	13.04	kr/s
TiCl	1.88	kr/s
TEMAHf	0.25	kr/s

The time is measured as the total time open to a given source during a deposition. So for instance if the TMA pulse time in a given run is 0.1 s and a total of 500 pulses are used, that equates to 50 s of TMA source for that run.

## 4 Equipment capabilities and charging categories



At DTU Nanolab we have equipment that supports most nanofabrication and -characterization techniques. In the following we present our current portfolio of tools and the associated charging category. We have the tools divided up into nine groups depending on their processing capability. We have also added a subgroup to better indicate the specific purpose of the tool and the location of the equipment (building/room).

Tools in category R are not for general use. They are owned by a research group or a company. If you are interested in one of these tools, please contact Fabrication Support ([sales@nanolab.dtu.dk](mailto:sales@nanolab.dtu.dk)) and we can facilitate a contact.

*Some tools are charged based on the booked time they are indicated with "Yes" in the column "Pay by booking"; otherwise charging is based on logged time.*

### 4.1 Lithography tools

We use lithography as a means to add or remove material in specific areas to create a pattern on a surface. DTU Nanolab supports several types of lithography spanning linewidth resolutions from around 10 nm and up.

The most common way of lithography is by using light to expose a sensitive film (resist) that was spun on a wafer/sample to obtain a thin uniform film. The pattern is revealed by placing the sample with the film in a developer. The developer is in this case typically a chemical etching solution consisting of a base and water.

Our standard tools for lithography uses UV light with a wavelength of 365 nm to 410 nm and you can typically achieve a line resolution of around 1-2  $\mu\text{m}$ . Exposure can be done using our mask aligner where the light passes a glass mask with the pattern defined in a chromium pattern or using our Mask Less Aligners (MLA) where the pattern only exists as a data file and the pattern is made during exposure using an advanced electro-optical system.

To obtain a better resolution please find more information in section 4.9.

Find more information about lithography in our LabAdviser using this link

[https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Lithography](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Lithography)

Name	LM nr	Cat.	Location	sub group
2PP printer	1.038	R	347/PolyFabLab	Exposure
Aligner: MA6-1	1.003	A	347/PolyFabLab	Aligner
Aligner: MA6-2	1.053	A	346/E-4	Aligner
Aligner: Maskless 01 (MLA1)	1.075	A	346/E-4	Aligner
Aligner: Maskless 02 (MLA2)	1.078	A	346/E-5	Aligner
Aligner: Maskless 03 (MLA3)	1.081	A	346/E-5	Aligner
Aligner: Maskless 04 ( $\mu$ MLA)	1.098	S	347/PolyFabLab	Exposure
Beamer PC - external	1.093	F	347/081	PC
Developer: SU8 (Wet Bench)	1.092	F	346/E-4	Developer
Developer: TMAH Manual 02	1.100	A	346/E-4	Developer
Developer: TMAH UV-lithography	1.050	A	346/E-4	Developer
Fume hood 09: UV development	1.067	F	346/E-4	Developer
Fume hood 10: e-beam development	1.068	F	346/E-4	Developer
Fume hood 11: Lithography cleaning	1.074	F	346/E-5	Wet clean

Name	LM nr	Cat.	Location	sub group
Hotplate 1 (SU8)	1.014	F	346/E-4	Hotplate
Hotplate 2 (SU8)	1.015	F	346/E-4	Hotplate
Hotplate 3 (SU8)	1.079	F	347/PolyFabLab	Hotplate
Hotplate 4 (SU8)	1.080	F	347/PolyFabLab	Hotplate
Hotplate: 90-110C	1.052	F	346/C-1	Hotplate
Imprinter 01 (100mm)	1.065	A	346/F-2	imprinter
Imprinter 03 (200mm)	1.096	A	347/PolyFabLab	imprinter
Imprinter 04 (110mm)	1.101	R	347/PolyFabLab	imprinter
Lift-off	1.060	A	346/D-3	
Micro Transfer Printer	1.090	A	346/F-1	
MVD	1.030	A	346/A-1	
Oven 250C	1.018	F	346/Cx1	Oven
Oven 250C for burned resist	1.019	F	346/C-1	Oven
Oven 90C	1.016	F	346/C-1	Oven
Oven: 110 - 250C	1.017	F	346/C-1	Oven
Oven: HMDS - 2	1.054	F	346/E-5	Oven
Plasma Asher 4	1.094	F	346/E-5	Plasma Asher
Plasma Asher 5	1.095	F	346/E-5	Plasma Asher
Program oven	1.020	F	346/C-1	Oven
Resist strip	1.061	F	346/D-3	
Spin Coater: Gamma e-beam & UV	1.071	A	346/E-5	Resist coater
Spin Coater: Gamma UV	1.055	A	346/E-5	Resist coater
Spin Coater: Labspin 02	1.057	A	346/E-5	Resist coater
Spin Coater: LabSpin 03	1.063	A	346/E-5	Resist coater
Spin Coater: LabSpin 04	1.099	S	347/PolyFabLab	Resist coater
Spin Coater: PDMS 1	1.103	A	347/084 PDMS	Resist coater
Spin Coater: RCD8	1.056	A	346/E-4	Resist coater
Spin coater: Süss Stepper	1.041	A	346/F-3	Resist coater
Spray Coater	1.042	A	346/Cx1	Resist coater
Wafer Bonder 02	1.058	B	346/E-4	Wafer bonder
Wafer Bonder 03	1.077	A	346/F-2	Wafer bonder
Wet bench 06: Resist strip	1.069	F	346/D-3	Bench
Wet bench 07: Lift-off	1.070	F	346/D-3	Bench
Wet bench 08: Spinner	1.072	F	346/E-5	Bench
Wet bench 09: Spinner	1.073	F	346/E-5	Bench
Wet bench 10: Developer	1.097	F	346/E-4	Bench
Fumehood(Manual Spinner)	3.020	F	346/C-1	Resist coater

## 4.2 Thin Film tools

There are many different methods to create thin films on samples. In this context we generally think of films having a layer thickness from one atomic layer up to a few micrometers.

The different techniques are usually named using an abbreviation like PVD (Physical Vapor Deposition), LPCVD (Low Pressure Chemical Vapor Deposition), PECVD (Plasma Enhanced Chemical Vapor Deposition) and ALD (Atomic Layer Deposition) and each has their pros and cons.

Find more information about deposition tools and techniques in LabAdviser using this link

[https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Thin\\_film\\_deposition](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Thin_film_deposition)

Name	LM nr	Cat.	Location	Process category	sub group
ALD 1	2.021	B	346/F-2	Thin Film	ALD
ALD 2 (PEALD)	2.023	B	346/F-2	Thin Film	ALD
E-Beam Evaporator (10-pockets)	2.035	B	346/A-5	Thin Film	Evaporator
E-Beam Evaporator (Temescal)	2.029	B	346/A-5	Thin Film	Evaporator
Furnace: LPCVD Nitride (4") (B2)	2.012	B	346/B-1	Thin Film	LPCVD
Furnace: LPCVD Nitride (6") (E3)	2.015	B	346/E-6	Thin Film	LPCVD
Furnace: LPCVD Poly-Si (4") (B4)	2.010	B	346/B-1	Thin Film	LPCVD
Furnace: LPCVD Poly-Si (6") (E2)	2.019	B	346/E-6	Thin Film	LPCVD
Furnace: LPCVD TEOS (B3)	2.011	B	346/B-1	Thin Film	LPCVD
P/S Sputter System	2.034	R	346/951	Thin Film	Sputtering
Parylene Coater 1	2.037	S	347/PolyFabLab	Thin Film	
PECVD3	2.009	B	346/A-1	Thin Film	PECVD
PECVD4	2.024	B	346/B-1	Thin Film	PECVD
Proline 200	2.032	B	346/904	Thin Film	Sputtering
Slot Die Coater: AlphaSC	2.036	S	347/PolyFabLab	Thin Film	
Sputter Coater 03	2.026	B	346/904	Thin Film	Sputtering
Sputter Coater 04	2.028	F	346/Cx1	Thin Film	Sputtering
Sputter-System Metal-Nitride (PC3)	2.031	B	346/A-5	Thin Film	Sputtering
Sputter-System Metal-Oxide (PC1)	2.030	B	346/A-5	Thin Film	Sputtering
Sputter-System (Lesker)	2.014	B	346/Ax2	Thin Film	Sputtering
Thermal Evaporator	2.027	B	346/A-1	Thin Film	Evaporator

### 4.3 Etch tools

Etching is a common way to remove material. We provide both wet and dry etching techniques. Wet etching is typically done using either a base or an acid to remove a selected material. One good thing about wet etching is that you can get a good selectivity so that only the material you want to remove is actually removed. However, wet etching is in most cases also isotropic meaning that the removal rate is the same in all directions. If you etch through a hole on the surface, you will get under-etching and sloped (rounded) walls. We provide both specialized wet stations for commonly used etchants and fume hoods for safe handling and etching in beakers.

Dry etching usually involves a vacuum chamber supplied with selected gasses and a plasma to make these gasses reactive. It is controlled and monitored using a computer. This gives a very good control of the process which you can vary from being very "wet etch" like to be more "physical" using bombardment of the surface with ions and radicals to remove material. You have better directionality with no under-etching the more "physical" the process is. At the same time you will, however, lose selectivity.

Find more information about wet and dry etching tools and techniques in LabAdviser using this link  
[https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Etch](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Etch)

Name	LM nr	Cat	Location	sub group
Aluminium Etch	3.041	F	346/D-3	Wet etch
AOE	3.001	B	346/B-1	Dry etch
ASE	3.002	B	346/B-1	Dry etch
Critical Point Dryer	3.025	A	346/D-3	
DRIE-Pegasus	3.027	B	346/A-1	Dry etch
DRIE-Pegasus 2	3.044	B	346/A-1	Dry etch
DRIE-Pegasus 3	3.051	B	346/C-1	Dry etch
DRIE-Pegasus 4	3.052	B	346/C-1	Dry etch
Fume hood 01: Acids/bases	3.031	F	346/D-3	Wet etch
Fume hood 02: Acids/bases	3.032	F	346/D-3	Wet etch
Fume hood 05: Special purpose & nanoparticles	3.033	F	346/D-3	
Fume hood 06: Si etch	3.034	F	346/D-3	Wet etch
Fume hood 07: III-V acids/bases	3.035	F	346/D-3	Wet etch
Fume Hood 12 (Standard clean)	3.057	F	346/B-1	Wet etch
Fume Hood PFL-01: Acids/Bases	3.059	F	347/PolyFabLab	Wet etch
Fume Hood (Service Area)	3.017	F	346/Bx1	Wet etch
Fumehood (Manual Spinner)	3.020	F	346/C-1	Resist coater
HF Vapour Phase Etcher 01	3.053	B	346/D-3	Wet etch
IBE/IBSD Ionfab 300	3.029	B	346/A-1	Dry etch
ICP Metal Etch	3.028	B	346/B-1	Dry etch
III-V ICP	3.055	B	346/B-1	Dry etch
Nitride etch: H <sub>3</sub> PO <sub>4</sub>	3.037	A	346/D-3	Wet etch
Oxide etch 1: BHF	3.042	F	346/D-3	Wet etch
Oxide etch 2: BHF (clean)	3.038	F	346/D-3	Wet etch
Oxide etch 3: 10% HF	3.040	F	346/D-3	Wet etch
PCB Etch	3.030	R	346/145	
Poly Si etch	3.039	F	346/D-3	Wet etch
Si Etch 1: KOH	3.036	A	346/D-3	Wet etch
Si Etch 2: KOH	3.043	A	346/D-3	Wet etch
Si Etch 3: KOH	3.045	A	346/D-3	Wet etch
Si-DRIE-Samco	3.061	B	346/?	Dry etch
Wet bench 01: Si etch	3.046	F	346/D-3	Wet etch
Wet bench 02: Nitride etch	3.047	F	346/D-3	Wet etch
Wet bench 04: Oxide & poly etch	3.048	F	346/D-3	Wet etch
Wet bench 05: Al etch	3.049	F	346/D-3	Wet etch
Wet Bench 10: Multipurpose	3.060	F	346/D-3	Wet etch
Work space in Fume Hood 06	3.050	F	346/D-3	Wet etch

#### 4.4 Wafer cleaning tools

In our processing it is very important to keep all surfaces clean of any contaminants due to the fine patterns and the use of different materials and chemicals. We therefore provides a range of tools and chemical benches/fume hoods to clean wafers and samples.

Find more information about wafer cleaning techniques in LabAdviser using this link

[https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Wafer\\_cleaning](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Wafer_cleaning)

Name	LM nr	Cat	Location	sub group
Box washer	4.018	F	346/D-1	Wet clean
Buffered HF-Predep	4.016	F	346/B-1	Wet clean
Cleaning bench	4.022	F	346/D-1	Wet clean
Cleaning Bench PolyFabLab	4.036	F	347/PolyFabLab	Wet clean
Fume hood 03: Solvents	4.026	F	346/D-3	Wet clean
Fume hood 04: Solvents	4.027	F	346/D-3	Wet clean
Fume hood 08: III-V solvents	4.028	F	346/D-3	Wet clean
Fume Hood PFL-02: Solvents	4.038	F	347/PolyFabLab	Wet clean
Fume Hood PFL-03: Solvents 3D	4.037	F	347/PolyFabLab	Wet clean
Fume Hood PFL-04: Spinner	4.039	F	347/PolyFabLab	Wet clean
Fume Hood PFL-05: Solvents	4.040	F	347/PolyFabLab	Wet clean
Fumehood (Cleaning)	4.023	F	346/F-2	Wet clean
Fumehood (Solvent 11)	4.024	F	346/F-2	Wet clean
Fumehood (Solvent 12)	4.025	F	346/F-2	Wet clean
HF 1% - RCA	4.015	F	346/B-1	Wet clean
Mask Cleaning	4.029	F	346/D-3	Wet clean
Plasma Cleaner 1: SurfacePrep	4.041	R	346/145	Plasma Asher
Plasma Cleaner 2: SurfacePrep	4.042	S	347/PolyFabLab	Plasma Asher
Post CMP cleaner	4.034	A	346/A-5	Wet clean
RCA (4" ,6")	4.014	F	346/B-1	Wet clean
RCA Clean (Automatic)*	4.043	B	346/D-2	Wet clean
Spin dryer 2	4.005	F	346/B-1	Drying
Spin dryer 3	4.013	F	346/D-3	Drying
Spin dryer 5 (4" ,6")	4.032	F	346/D-3	Drying
Spin dryer (6" ,8")	4.021	F	346/D-3	Drying
Wafer Cleaning	4.030	F	346/D-3	Wet clean
Wet bench 03: Wafer and mask cleaning	4.033	F	346/D-3	Wet clean

\* Will be installed in 2026

#### 4.5 Thermal process tools

One of the basic processes in Silicon microfabrication is the ability to form a very good insulating layer on top of the semiconductor. This is done in a thermal process where you subject the silicon wafer to moisture or dry oxygen at a high temperature around 1000°C. This oxidizes the surface and creates a silicon dioxide layer out of the topmost silicon atoms. This is an extremely well controlled process and creates SiO<sub>2</sub> of high optical, chemical and physical quality. By patterning the surface and etching the SiO<sub>2</sub> you can also use the remaining SiO<sub>2</sub> layer as a barrier to control diffusion of selected

impurity atoms to create n- and p-type Silicon. Our range of furnaces supports both this process but also other processes for wafer bonding and thermal treatment of samples.

Find more information about oxidation and thermal treatment tools in LabAdviser using this link [https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Thermal\\_Process](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Thermal_Process)

Name	LM nr	Cat	Location	sub group
BCB Curing Oven	5.015	A	346/Cx1	Annealing
Furnace: Al-Anneal (C4)	5.005	A	346/B-1	Annealing
Furnace: Anneal-bond (C3)	5.008	A	346/B-1	Annealing
Furnace: Anneal-oxide (C1)	5.006	A	346/B-1	Annealing
Furnace: Boron Drive-in and Pre-dep (A1)	5.004	A	346/B-1	Oxidation
Furnace: Gate Oxide (A2)	5.003	A	346/B-1	Oxidation
Furnace: General Purpose Annealing (C2)	5.007	A	346/B-1	Annealing
Furnace: Oxidation (8") (E1)	5.019	A	346/E-6	Oxidation
Furnace: Phosphorus Drive-in (A3)	5.002	A	346/B-1	Oxidation
Furnace: Phosphorus Predep (A4)	5.001	A	346/B-1	Oxidation
Furnace: Resist Pyrolysis	5.016	R	346/B-1	Annealing
RTP Annealsys	5.017	R	346/B-1	Annealing
RTP2 Jipelec	5.018	A	346/A-5	Annealing

#### 4.6 SEM/TEM Preparation and Characterization Tools (located in building 307/314)

DTU Nanolab has a long tradition of research and development of Scanning- and Transmission Electron Microscopy (SEM and TEM) using advanced detectors and in-situ measurements techniques. Currently we are also expanding our capabilities to prepare soft matter tissues and samples.

Find more information about our SEM/TEM preparation and characterization tools in LabAdviser using this link

<https://labadviser.nanolab.dtu.dk/index.php?title=LabAdviser/314>

Name	LM nr	Cat	Location	sub group	Pay by booking
<b>AFEG 250 Analytical ESEM</b>	6.018	D	314/034 AFEG	SEM	Yes
<b>Carbon Coater</b>	6.014	P	314/063 Prep3	SEM	
<b>Coater EM ACE600 B314</b>	6.046	P	314/040 Prep2	prep	
<b>Cryo Holder ST</b>	6.021	P	314/040 Prep2	prep	
<b>DENS Wildfire</b>	6.042	P	314/040 Prep2	TEM	
<b>DENSsolutions Climate</b>	6.036	R	314/037 ETEM	TEM	
<b>EM ACE600 Coater Softmatter</b>	6.043	P	307/907 Softmat	prep	
<b>EM AFS2 Freeze substitution</b>	6.044	P	307/903 Softmat	prep	
<b>EM CPD300 Critical Point Dryer</b>	6.024	P	307/903 Softmat	prep	

<b>EM GP2 Plunge freezer</b>	6.019	P	307/909B Cryo	prep	
<b>EM ICE High pressure freezer</b>	6.045	P	307/909B Cryo	prep	
<b>EM UC7/FC7 Ultramicrotome</b>	6.023	P	307/909B Cryo	prep	
<b>FlatQUAD detector</b>	6.040	P	314/011 Helios	SEM	
<b>Helios Hydra PFIB</b>	6.038	E	314/061 Hydra)	SEM	Yes
<b>Helios NanoLAB 600</b>	6.005	E	314/011 Helios	SEM	Yes
<b>Minitom Saw</b>	6.028	P	314/033 Prep1	prep	
<b>Nano Mill</b>	6.000	P	314/035 Lounge	prep	Yes
<b>Nova NanoSEM 600</b>	6.011	E	314/060 Verios	SEM	Yes
<b>Olympus BX51</b>	6.022	R	307/113 Optical	Optical	
<b>Olympus BX51 stage</b>	6.025	P	314/033 Prep1	Accessory	
<b>Protochips Fusion</b>	6.037	P	314/037 ETEM	TEM	
<b>Pumping cube</b>	6.001	P	307/111 T12		
<b>QFEG 200 Cryo ESEM</b>	6.003	D	307/907 Softmat	SEM	Yes
<b>Quorum Coater</b>	6.013	P	314/063 Prep3	prep	
<b>Remote Access Laptop 1</b>	6.035	R	314/035 Lounge		
<b>Spectra Ultra</b>	6.041	E	314/042 Ultra	TEM	Yes
<b>Talos TEM</b>	6.048	D	313/921D Talos	TEM	Yes
<b>TechPrep</b>	6.027	P	314/033 Prep1	prep	
<b>Tecnai T12 BioTwin</b>	6.015	R	307/111 T12	TEM	Yes
<b>Tecnai T20 G2</b>	6.006	D	314/014 T20	TEM	Yes
<b>Titan E-Cell 80-300ST</b>	6.008	E	314/037 ETEM	TEM	Yes
<b>Verios SEM</b>	6.047	D	314/060 Verios	SEM	Yes
<b>Well wire saw</b>	6.030	P	314/033 Prep1	prep	

#### 4.7 Backend tools

We have a number of tools dedicated to separating wafers into chips, packaging of these or other kind of treatment. These tools are typically located outside of the cleanrooms and used as the last step of the process.

We also have a range of 3D printing tools that can make structures with a resolution down to a few microns. These tools are placed in PolyFabLab.

Find more information about our Backend processing tools in LabAdvisor using this link

[https://labadvisor.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Back-end\\_processing](https://labadvisor.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Back-end_processing)

Name	LM nr	Cat	Location	sub group
3D Printer	7.020	R	345C/072	3D printer
3D Printer 02 (BMF S140)	7.035	R	347/PolyFabLab	3D printer
3D Printer 03 (BMF S240)	7.036	R	347/PolyFabLab	3D printer
3D Printer 04 (BMF S230)	7.037	S	347/PolyFabLab	3D printer
Ball wire-bonder	7.012	A	346/151	Packaging
Cleaver: Flex Scribe	7.029	F	346/D-3	Dicing
Cleaver: Flip Scribe	7.028	F	346/D-3	Dicing
Cleaver: Lattice Axe	7.027	F	346/D-3	Dicing
Dicing Saw DAD321 (old)	7.006	A	346/157	Dicing
Dicing saw DAD3241	7.030	A	346/157	Dicing

Hot embosser 1	7.025	A	346/901 laser	
Inkjet Printing System (Autodrop)	7.038	A	347/PolyFabLab	
Laser Micromachining Tool	7.013	A	346/901 laser	
Oven: PDMS	7.041	F	347/084 PDMS	Oven
Plasma Asher 3: Descum	7.021	A	346/A-5	Plasma Asher
Plasma Cleaner 3: PDMS	7.040	S	347/084 PDMS	Plasma Asher
Polisher/CMP	7.024	A	346/A-5	
Pull- and Shear-tester: xyztec	7.039	A	347/080 Sup.Lab	Packaging
Tribometer	7.043	R	347/PolyFabLab	
Vacuum sealer: Boss	7.033	F	346/Cx1	
Wafer Cleaner Disco DCS1441	7.031	F	346/157	Dicing
Quantum X 2PP	7.045	A	347/PolyFabLab	Packaging
Wafer Grinder DAG810	7.042	A	347/074 Sup.Lab	
Wire bonder: tpt HB100	7.034	A	347/080 Sup.Lab	Packaging

#### 4.8 Cleanroom characterization tools

In order to verify that you are processing what you intend to fabricate you need inline inspection and characterization equipment. Our Cleanroom is equipped with all standard nanotechnology inspection tools. We also have a range of duplicated or other tools placed outside the cleanrooms (many in the basement of building 346) for further inspection of fabricated devices.

Find more information about our Cleanroom Characterization tools in LabAdviser using this link [https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Characterization](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Characterization)

Name	LM nr	Cat	Location	sub group
AFM Icon-PT 1	8.048	A	346/C-1	Profiling
AFM Icon-PT 2	8.058	A	346/904	Profiling
Dektak 3ST stylus profiler	8.070	A	346/904	Profiling
DektakXTA	8.040	F	346/B-1	Profiling
Drop Shape Analyzer 02	8.076	F	346/A-1	Optical
Ellipsometer M-2000V	8.024	F	346/F-2	Optical
Ellipsometer RC2	8.081	F	346/A-1	Optical
Ellipsometer VASE	8.045	F	346/C-1	Optical
Filmtek	8.018	F	346/A-1	Optical
Four Point Probe	8.014	A	346/151	Electrical
Four point probe - Jandel	8.060	F	346/D-3	Electrical
Goniometer - contact angle meter	8.075	R	347/074 SupportLab	Optical
Hardness tester	8.057	F	347/074 SupportLab	
IR-Camera	8.010	F	346/Cx1	Optical
Laser Confocal Scanning Microscope	8.079	S	347/PolyFabLab	Optical
Leica INM 100 (yellow filter)	8.033	A	346/901 Laser	Optical
Leica S8 APO	8.030	F	346/Cx1	Optical
Leitz Medilux	8.032	F	346/D-3	Optical
Lifetime scanner MDPmap	8.049	F	346/A-3	Electrical
Microscope Olympus MX63	8.083	F	346/E-5	Optical
Microscope: Keyence VHX-X1	8.078	S	347/PolyFabLab	Optical

Microscope: Nikon ECLIPSE L200 1	8.025	F	346/D-3	Optical
Microscope: Nikon ECLIPSE L200 2	8.044	F	346/D-3	Optical
Microscope: Nikon ECLIPSE L200N 3	8.053	F	346/E-4	Optical
Microscope: Nikon ECLIPSE L200N 4	8.054	F	346/E-5	Optical
Microscope: NILT Nikon L300N	8.065	R	346/C-1	Optical
Microscope: Zeiss Axiotron 2	8.043	F	346/F-3	Optical
Microscope: Zeiss Jenatech (particle meas.)	8.034	F	346/A-1	Optical
MicroSpectroPhotometer (Craic 20/30 PV)	8.066	A	346/F-1	Optical
NanoprobeSystem_miBots	8.069	F	346/904	Electrical
Nikon ME 600	8.037	F	346/F-1	Optical
Noco IR microscope	8.035	A	346/901 Laser	Optical
Optical Microscope 11	8.041	P	307/111 (T12)	Optical
Optical Profiler (Filmetrics)	8.064	A	346/904	Optical
Optical Profiler (Sensofar S Neox)	8.068	F	346/C-1	Optical
Particle Scanner Takano	8.073	A	346/F-2	Optical
PL mapper YSystems	8.086	A	346/?	Optical
PL-mapper	8.071	A	346/F-1	Optical
Probe station 3 - EPS150Triax	8.051	F	346/Cx1	Electrical
Probe station 4: MPS150	8.080	A	346/151	Electrical
SEM Gemini 1	8.072	D	346/B-1	SEM
SEM Supra 1	8.026	D	346/904	SEM
SEM Supra 2	8.047	D	346/C-1	SEM
SEM Supra 3	8.052	D	346/C-1	SEM
SEM Tabletop 1	8.055	A	347/074 SupportLab	SEM
Stylus Profiler (Tencor P17)	8.067	F	346/F-2	Profiling
Stylus profiler: Dektak 150	7.026	A	347/074 SupportLab	Profiling
TGA-150 Analyzer	8.085	A	346/?	weight
Thickness measurer	8.021	F	346/D-3	Profiling
XPS K-Alpha	8.027	A	346/904	XPS
XPS Nexsa	8.062	A	346/904	XPS
XRD Powder	8.061	A	346/901 Laser	X-ray
XRD RotAnode	8.077	A	346/901 Laser	X-ray
XRD SmartLab	8.056	A	346/F-2	X-ray
Zeiss Jenatech (strain)	8.028	F	346/?	Optical

#### 4.9 E-beam writer & DUV stepper tools

To achieve patterns with a resolution of better than 1  $\mu\text{m}$  you can use our DUV stepper. Here the pattern is again defined in a glass mask with a chromium layer and the exposure is done using DUV light with a wavelength of 248 nm and an optical system that reduces the pattern on the mask with a factor of 5. In this way a resolution of around 200 nm is possible and since the machine has automatic wafer loading a high throughput of wafers can be achieved.

The finest patterns are obtained using e-beam lithography where a beam of electrons exposes an electron sensitive resist followed by development in a solvent. In this way a resolution of down to 10 nm is possible.

Find more information about our e-beam writer and DUV Stepper tools in LabAdviser using these links

[https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Lithography/EBeamLithography](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Lithography/EBeamLithography)

[https://labadviser.nanolab.dtu.dk/index.php?title=Specific\\_Process\\_Knowledge/Lithography/DUVStepperLithography](https://labadviser.nanolab.dtu.dk/index.php?title=Specific_Process_Knowledge/Lithography/DUVStepperLithography)

Name	LM nr	Cat	Location	sub group
Developer: E-beam 02	9.012	A	346/E-4	Developer
Developer: TMAH Stepper	9.007	A	346/F-3	Developer
DUV Stepper	9.003	C	346/F-3	Exposure
E-Beam Writer 9500	9.004	C	346/E-2	Exposure
Fume Hood (Stepper)	9.005	F	346/F-3	Developer
Prealigner 02	9.009	F	346/E-2	Exposure
Raith e-LINE	9.010	D	346/C-1	Exposure

## 5 Tool changes

A vast number of DTU Nanolab’s tools can operate with different substrate sizes, chucks, materials or similarly. The consequences of various changes are described in the following sections. Regarding pricing, all scheduled changes are included in the tool cost but all non-scheduled changes result in a specific charge.

### 5.1 Scheduled routine changes

Some tools are changed on a weekly basis. To request a change a mail must be send to a “Change responsible”, who is in charge of the change plan for the tool. The change responsible will return by email to acknowledge the request and inform about when the request can be met. When we have made the change to the tool, we update the status log in LabManager.

Scheduled routinely changed tools	LM ID	Routine change	Cost (DTU Nanolab assistance)	Change responsible e-mail
Temescal	2.029	Metals	2 hours	<a href="mailto:metal@nanolab.dtu.dk">metal@nanolab.dtu.dk</a>
Sputter-System Metal-Oxide	2.030	Materials	2 hours	<a href="mailto:metal@nanolab.dtu.dk">metal@nanolab.dtu.dk</a>
Sputter-System Metal-Nitride	2.031	Materials	2 hours	<a href="mailto:metal@nanolab.dtu.dk">metal@nanolab.dtu.dk</a>
Sputter System (Lesker)	2.014	Materials	2 hours	<a href="mailto:metal@nanolab.dtu.dk">metal@nanolab.dtu.dk</a>
Dicer DAD321	7.006	Dicing blade	1 hour	<a href="mailto:nanolabupport@nanolab.dtu.dk">nanolabupport@nanolab.dtu.dk</a>
Dicer DAD3241	7.030	Dicing blade	1 hour	<a href="mailto:nanolabupport@nanolab.dtu.dk">nanolabupport@nanolab.dtu.dk</a>